類組:<u>電機類</u> 科目:<u>固態電子元件(300G)</u>

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※請在答案卷內作答

(以下均為問答題)

- 1. (10%) Silicon semiconductor material in thermal equilibrium
 - (a) Prove the intrinsic **Fermi-level (E**_{Fi}) **position** of Silicon is close to the middle of energy bandgap (E_{midgap}). (5%)
 - (b) Please derive nopo product of Si, and give a brief description of the results. (5%)
- 2. (10%) The Hall Effect

A bulk semiconductor with length=L, width=W, thickness=d, voltage=V_H, voltage=V_x, current=I_x, under magnetic field (0, 0, B_z), is shown in **Figure 1**.

- (a) Determine the hole concentration p in terms of the parameters given above. (5%)
- (b) According to the result of (a), determine the hole mobility μ_{p} . (5%)

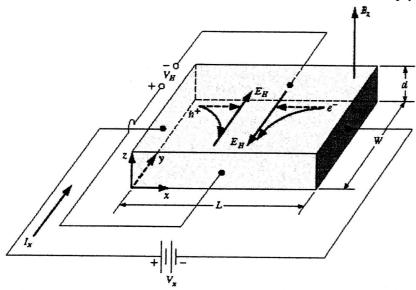




Figure 1 Geometry for measuring the Hall Effect.

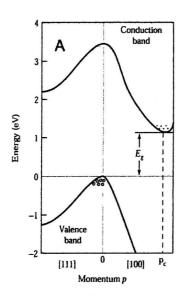
- 3. (15%) According to Figure 2, answer the 3 questions
 - (a) Define what a direct or indirect bandgap semiconductor is. And explain which category A and B belong to, respectively. (5%)
 - (b) For light emission diode (LED), semiconductor A or B, which one is suitable for LED application? (5%)
 - (c) Define the **effective mass (m*)**. Semiconductor A or B, which one has higher electron effective mass? (5%)

注意:背面有試題

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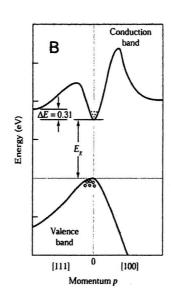


Figure 2

- 4. (20%) An abrupt Si p-n junction has doping concentrations $N_a = 10^{17}$ cm⁻³ on the p side and $N_d = 10^{16}$ cm⁻³ on the n side.
 - (a) At 300 K, draw an equilibrium energy band diagram for this p-n junction in which the Fermi level and the built-in potential energy are clearly indicated. Please write the expressions for calculating the positions of the Fermi level and the built-in potential energy. (15%)
 - (b) Is the junction located closer to the p- or n-neutral region? Why? (5%)
- 5. (10%) For a BJT, if the doping concentration in the base region is increased, which and how the properties of the BJT will be affected? Please list and describe at least two properties. (10%)
- 6. (15%) Consider a MOS capacitor shown in Figure 3, answer the following questions.
 - (a) Draw the energy band diagram (Ec, Ev, Ei, Fermi level) for cross-section A-A' with zero bias on the gate. (5%)
 - (b) Use p+ poly gate to replace n+ poly gate, draw the energy band diagram (Ec, Ev, Ei, Fermi level) for cross-section A-A'. (5%)
 - (c) Following (b), draw the energy band diagram (Ec, Ev, Ei, Fermi level) with a negative voltage (VGB) on p+ poly gate. (5%)

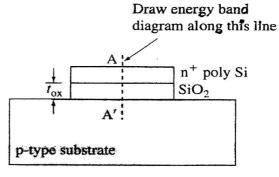


Figure 3

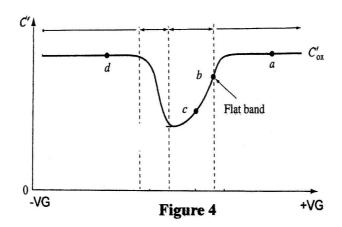
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- 7. (10%) For the C-V curve of a MOS capacitor with a p+ poly-Si gate shown in Figure 4, answer the following questions.
 - (a) What is the substrate type (n or p)? (3%)
 - (b) Which region (a, b, c, or d) indicates inversion? (3%)
 - (c) Draw and compare the C-V curves of another sample with increased the substrate doping level. (4%)



- 8. (10%) Consider the following effects on a MOSFET: (1) Channel Length Modulation (2) Body effect (3) Velocity Saturation,
 - (a) When its gate dielectric thickness decreases, which effects become more prominent? Explain why? (5%)
 - (b) When its channel length decreases, which effects become more prominent? Explain why? (5%)